

# HCZ120N40M1

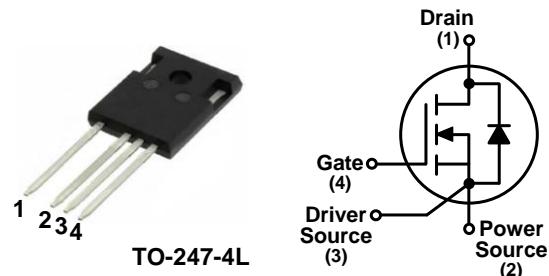
## N-Channel eSiC Silicon Carbide Power MOSFET

1200 V, 60 A, 40 mΩ

### Features

- High switching speed with a low gate charge
- Fast intrinsic diode with low reverse recovery
- Robust Avalanche Capability
- 100% Avalanche Tested
- Pb-free, Halogen Free, and RoHS Compliant

$BV_{DSS}$ , $T_c=25^\circ\text{C}$	$I_D$ , $T_c=25^\circ\text{C}$	$R_{DS(on),typ}$	$Q_{g,typ}$
1200 V	60 A	40 mΩ	104 nC



### Applications

- Solar inverter
- EV charging station
- UPS
- Industrial power supply

### Absolute Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter		Value	Unit
$V_{DSS}$	Drain to Source Voltage		1200	V
$V_{GS}$	Gate to Source Voltage (DC)		-10 / +22	V
$V_{GSop}$	Recommended Operation Value		-5 / +18	V
$I_D$	Drain Current	Continuous ( $T_c = 25^\circ\text{C}$ )	60	A
		Continuous ( $T_c = 100^\circ\text{C}$ )	43	
$I_{DM}$	Drain Current	Pulsed (Note1)	160	A
$P_D$	Power Dissipation	( $T_c = 25^\circ\text{C}$ )	319	W
		Derate Above 25°C	2.1	W/°C
$T_J$ , $T_{STG}$	Operating and Storage Temperature Range		-55 to 175	°C
$T_L$	Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds		260	°C

※Note 1 : Limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.47	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

### Package Marking and Ordering Information

Part Number	Top Marking	Package	Packing Method	Quantity
HCZ120N40M1	HCZ120N40M1	TO-247-4L	Tube	30 units

**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain to Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 1 \text{ mA}$	1200			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = 0 \text{ V}$		1	100	$\mu\text{A}$
		$V_{\text{DS}} = 1200 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 175^\circ\text{C}$		10		
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}} = +22 \text{ V}, V_{\text{DS}} = 0 \text{ V}$			+100	$\text{nA}$
		$V_{\text{GS}} = -10 \text{ V}, V_{\text{DS}} = 0 \text{ V}$			-100	

**On Characteristics**

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}} = V_{\text{DS}}, I_D = 10 \text{ mA}$ (tested after $V_{\text{GS}} = 22 \text{ V}, 1 \text{ ms pulse}$ )	2.0	3.0	4.5	V
$R_{\text{DS(on)}}$	Static Drain to Source On Resistance	$V_{\text{GS}} = 18 \text{ V}, I_D = 30 \text{ A}$		40	56	$\text{m}\Omega$
		$V_{\text{GS}} = 18 \text{ V}, I_D = 30 \text{ A}, T_J = 175^\circ\text{C}$		64		
$g_{\text{fs}}$	Transconductance	$V_{\text{DS}} = 20 \text{ V}, I_D = 30 \text{ A}$		16.1		S

**Dynamic Characteristics**

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 800 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 250 \text{ kHz}$		1963		$\text{pF}$
$C_{\text{oss}}$	Output Capacitance			124		
$C_{\text{rss}}$	Reverse Capacitance			9		
$E_{\text{oss}}$	Stored Energy in Output Capacitance	$V_{\text{DS}} = 0 \text{ V to } 800 \text{ V}, V_{\text{GS}} = 0 \text{ V}$		51		$\mu\text{J}$
$C_{\text{o(er)}}$	Energy Related Output Capacitance			160		
$C_{\text{o(tr)}}$	Time Related Output Capacitance			261		
$Q_{\text{g(tot)}}$	Total Gate Charge	$V_{\text{DS}} = 800 \text{ V}, I_D = 30 \text{ A}, V_{\text{GS}} = -5 \text{ V / } 18 \text{ V, Inductive load}$		104		$\text{nC}$
$Q_{\text{gs}}$	Gate to Source Charge			27		
$Q_{\text{gd}}$	Gate to Drain "Miller" Charge			34		
$R_G$	Internal Gate Resistance	$f = 1\text{MHz}$		3.5		$\Omega$

**Switching Characteristics**

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DS}} = 800 \text{ V}, I_D = 30 \text{ A}, V_{\text{GS}} = -5 \text{ V / } 18 \text{ V, R}_G = 2 \Omega, \text{ FWD : PCH120S20D1, Inductive load}$		20		$\text{ns}$
$t_r$	Turn-On Rise Time			15		
$t_{\text{d(off)}}$	Turn-Off Delay Time			37		
$t_f$	Turn-Off Fall Time			8		
$E_{\text{on}}$	Turn-on Switching Energy			210		
$E_{\text{off}}$	Turn-off Switching Energy			98		
$E_{\text{tot}}$	Total Switching Energy			308		

**Source-Drain Diode Characteristics**

$I_S$	Maximum Continuous Diode Forward Current			60		$\text{A}$
$I_{\text{SM}}$	Maximum Pulsed Diode Forward Current				160	
$V_{\text{SD}}$	Diode Forward Voltage	$V_{\text{GS}} = -5 \text{ V}, I_{\text{SD}} = 30 \text{ A}$		4.1		V
$t_{\text{rr}}$	Reverse Recovery Time	$V_{\text{DD}} = 800 \text{ V}, I_{\text{SD}} = 30 \text{ A}, dI_F/dt = 3000 \text{ A}/\mu\text{s, Includes Q}_{\text{oss}}$		16		$\text{ns}$
$Q_{\text{rr}}$	Reverse Recovery Charge			240		

## Typical Performance Characteristics

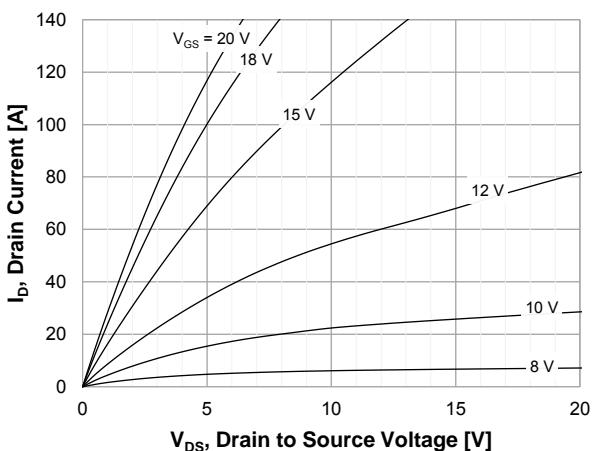
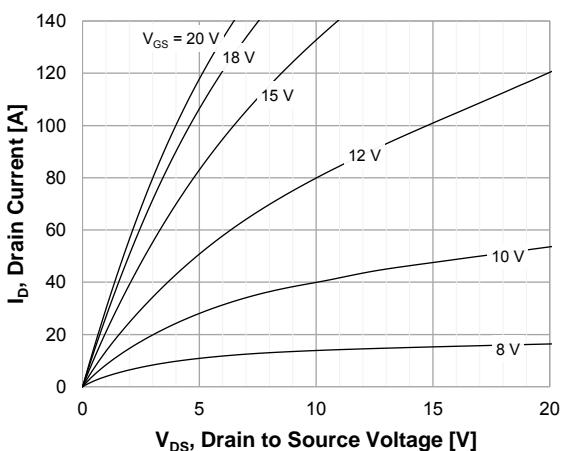
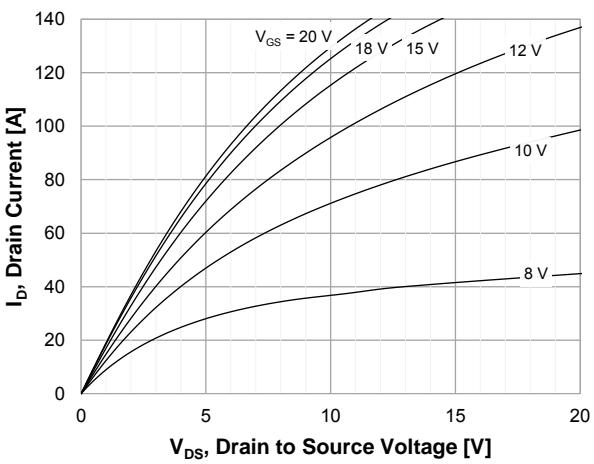
Figure 1. On-Region Characteristics  $T_J = -40^\circ\text{C}$ Figure 2. On-Region Characteristics  $T_J = 25^\circ\text{C}$ Figure 3. On-Region Characteristics  $T_J = 175^\circ\text{C}$ 

Figure 4. Normalized On-Resistance Characteristics vs. Temperature

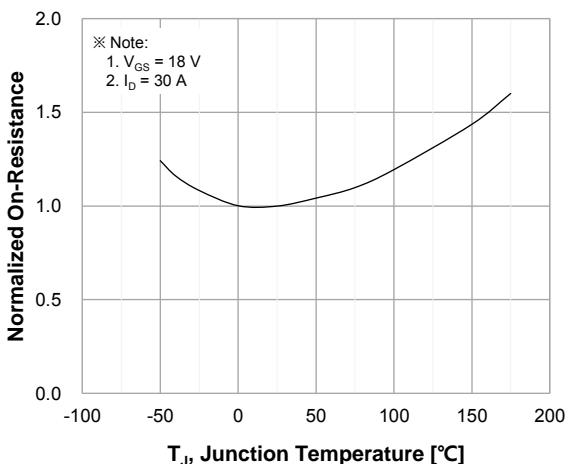
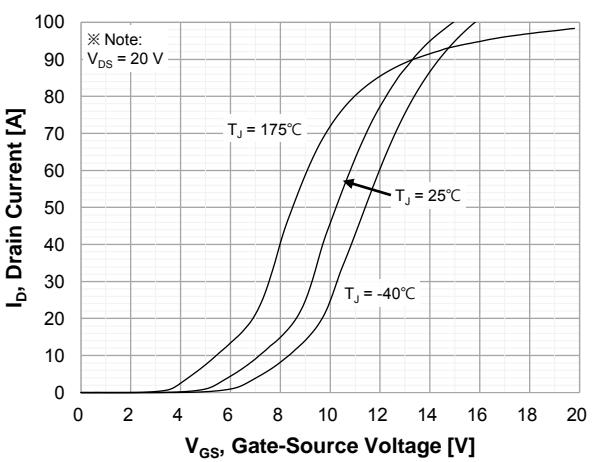
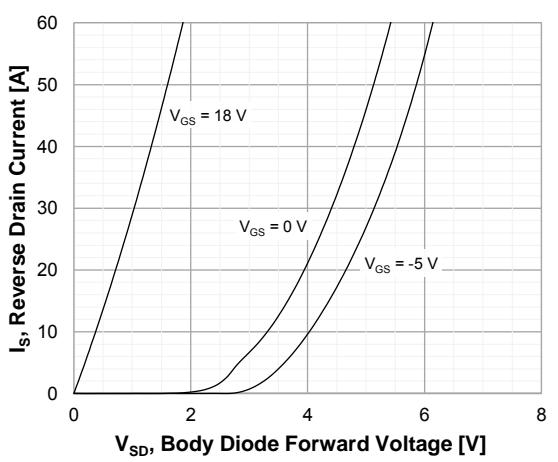
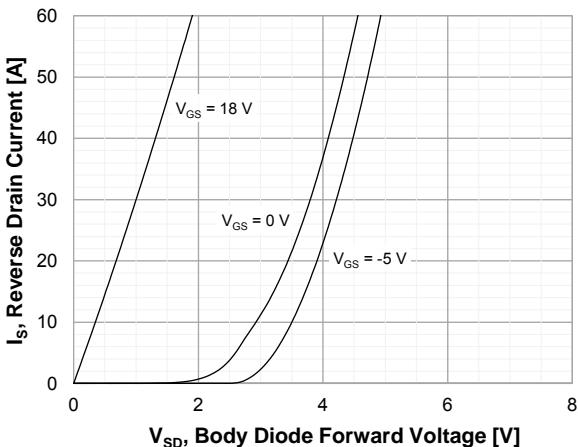


Figure 5. Transfer Characteristics

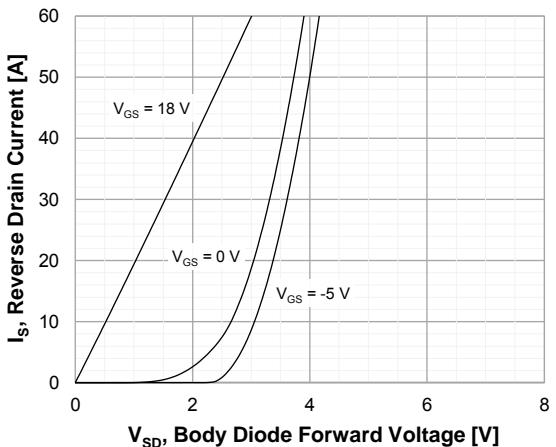
Figure 6. Diode Forward Voltage Characteristics vs. Source-Drain Current  $T_J = -40^\circ\text{C}$ 

### Typical Performance Characteristics

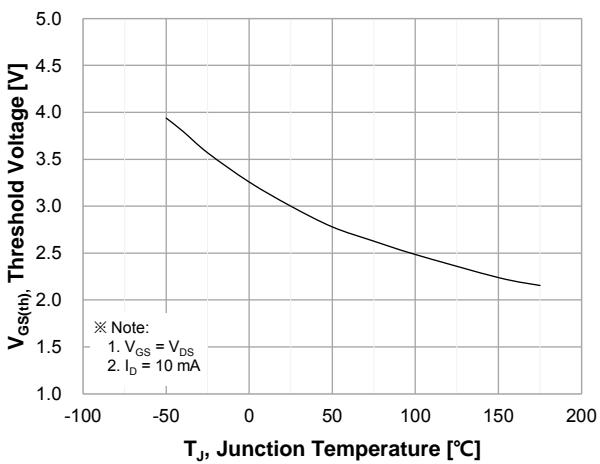
**Figure 7. Diode Forward Voltage Characteristics vs. Source-Drain Current  $T_J = 25^\circ\text{C}$**



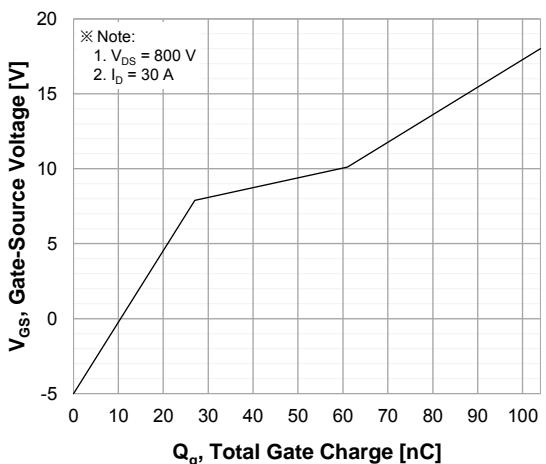
**Figure 8. Diode Forward Voltage Characteristics vs. Source-Drain Current  $T_J = 175^\circ\text{C}$**



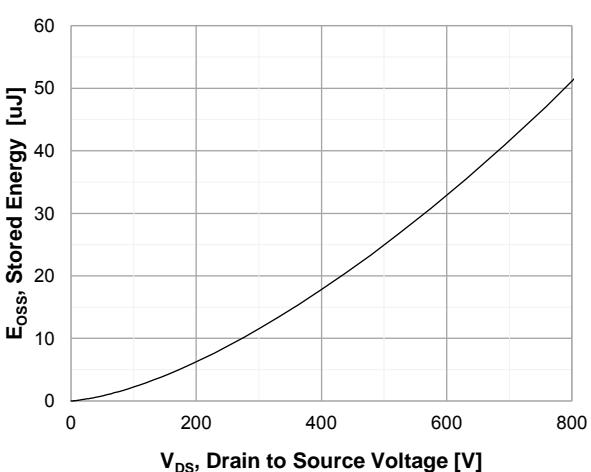
**Figure 9. Threshold Voltage vs. Temperature**



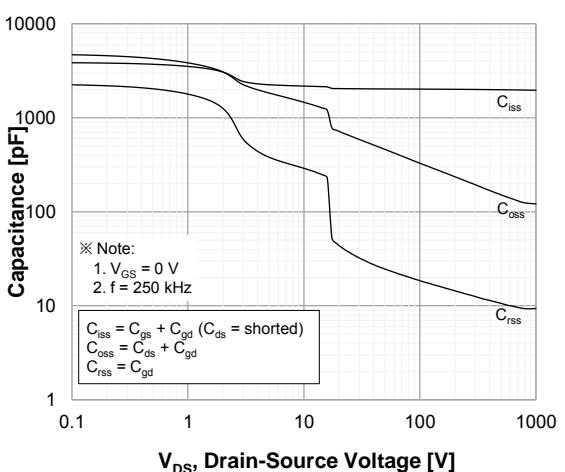
**Figure 10. Gate Charge Characteristics**



**Figure 11. Stored Energy in Output Capacitance**

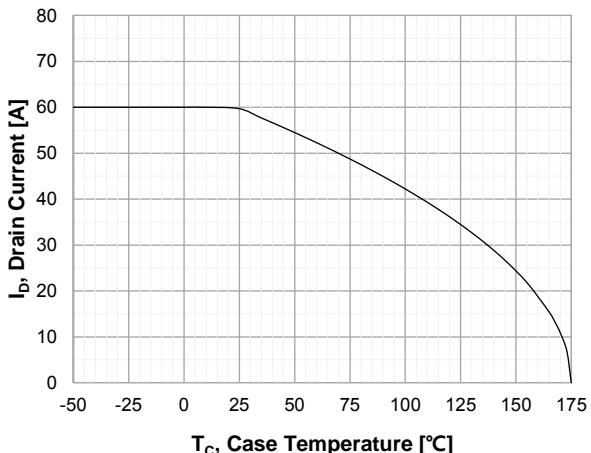


**Figure 12. Capacitance Characteristics**

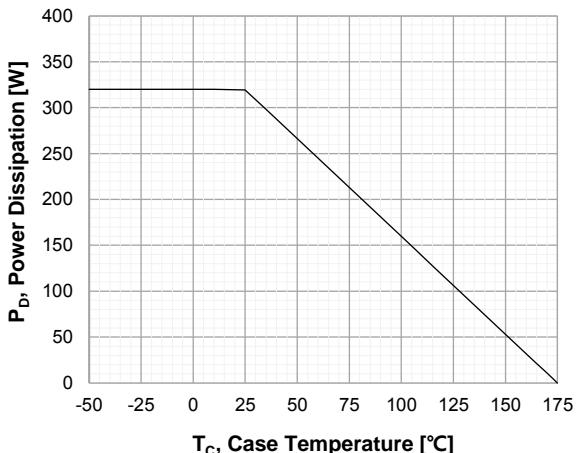


### Typical Performance Characteristics

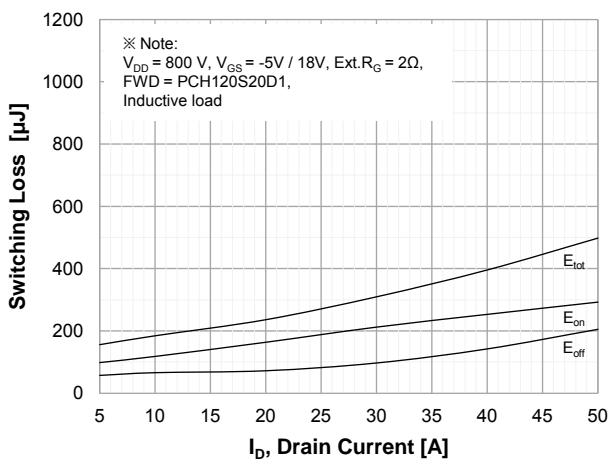
**Figure 13. Continuous Drain Current Derating vs. Case Temperature**



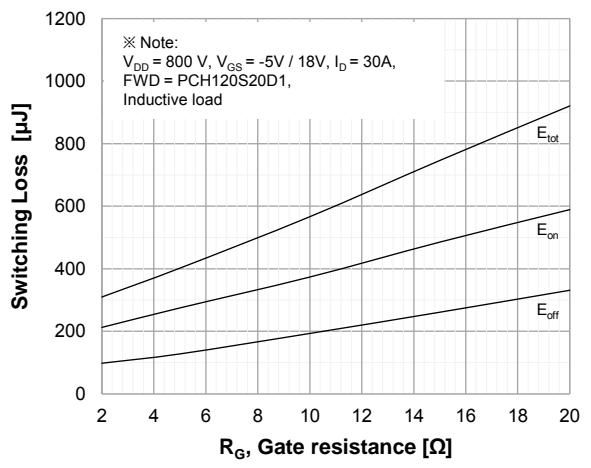
**Figure 14. Maximum Power Dissipation Derating vs. Case Temperature**



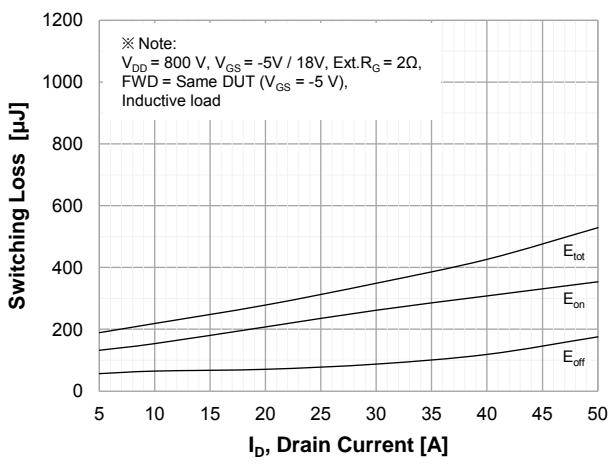
**Figure 15. Typ. Switching Losses vs. Drain Current**



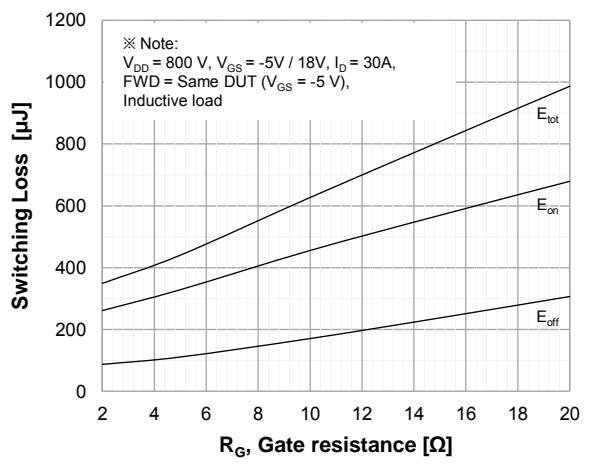
**Figure 16. Typ. Switching Losses vs. Gate Resistance**



**Figure 17. Typ. Switching Losses vs. Drain Current**



**Figure 18. Typ. Switching Losses vs. Gate Resistance**



## Typical Performance Characteristics

Figure 19. Maximum Safe Operating Area

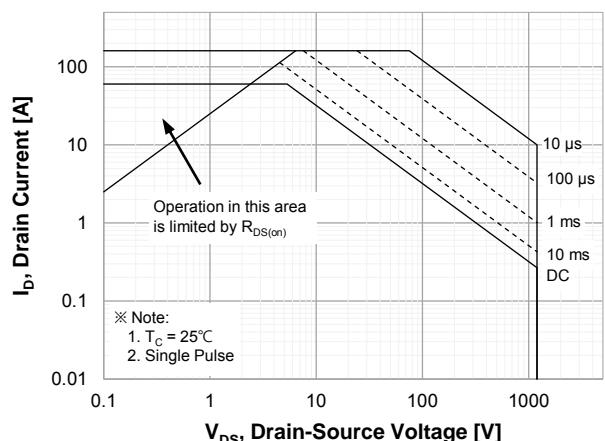


Figure 20. Transient Thermal Response Curve

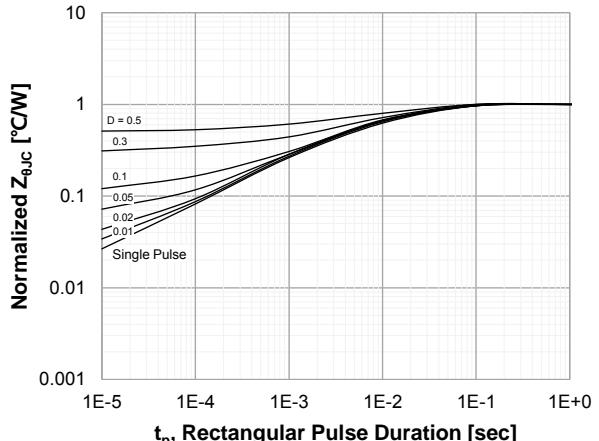


Figure 21. Inductive Load Switching Test Circuit and Waveforms

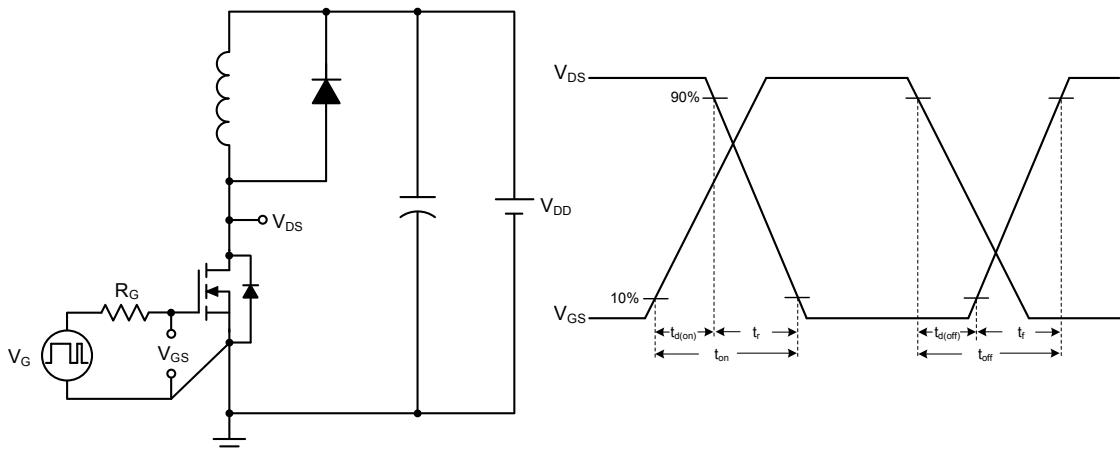
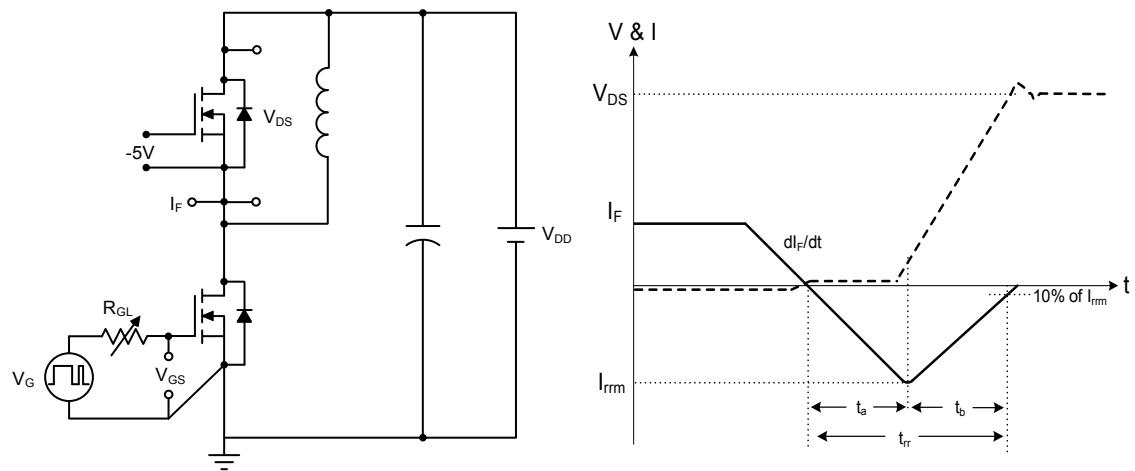
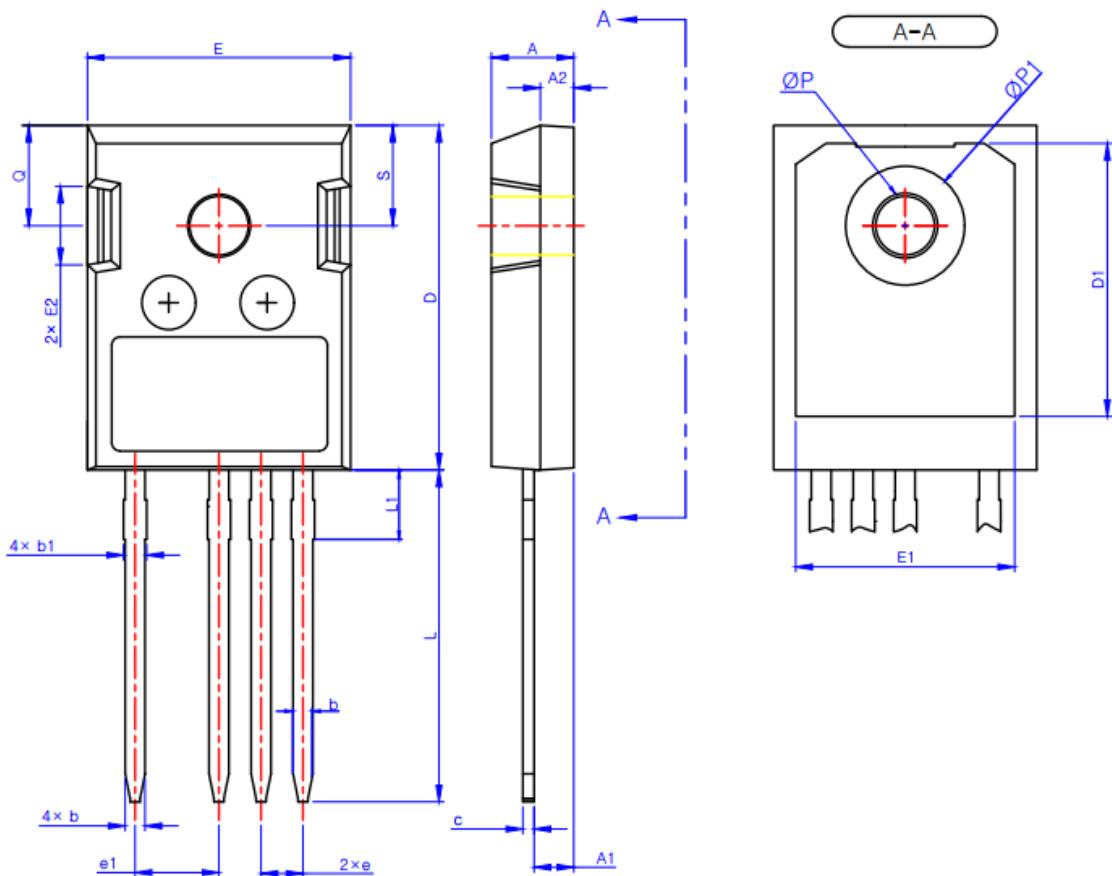


Figure 22. Peak Diode Recovery dv/dt Test Circuit and Waveforms



## Package Outlines

## TO-247-4L



SYMBOL	MIN	MAX
A	4.80	5.20
A1	2.29	2.54
A2	1.90	2.10
b	1.10	1.30
b1	1.30	1.50
c	0.50	0.70
D	20.80	21.10
D1	17.43	17.83
E	15.75	16.13
E1	13.06	13.46
E2	4.32	4.83
e	2.54 BSC	
e1	5.08 BSC	
L	19.85	20.25
L1	—	4.49
ØP	3.55	3.65
ØP1	7.00	7.40
Q	5.59	6.19
S	6.15 BSC	
S	6.15 BSC	

\* Dimensions in millimeters